

15-213

Memory Technology Oct 5, 2000

Topics

- Memory Hierarchy Basics
- Static RAM
- Dynamic RAM
- Magnetic Disks
- Access Time Gap

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Impact of Technology

Moore's Law

- Observation by Gordon Moore, Intel founder, in 1971
- Transistors / Chip doubles every 18 months
 - Has expanded to include processor speed, disk capacity, ...

We Owe a Lot to the Technologists

- Computer science has ridden the wave

Things Aren't Over Yet

- Technology will continue to progress along current growth curves
- For at least 7–10 more years
- Difficult technical challenges in doing so

Even Technologists Can't Beat Laws of Physics

- Quantum effects create fundamental limits as approach atomic scale
- Opportunities for new devices

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Impact of Moore's Law

Moore's Law

- Performance factors of systems built with integrated circuit technology follow exponential curve
- E.g., computer speed / memory capacities double every 1.5 years

Implications

- Computers 10 years from now will run 100 X faster
- Problems that appear intractable today will be straightforward
- Must not limit future planning with today's technology

Example Application Domains

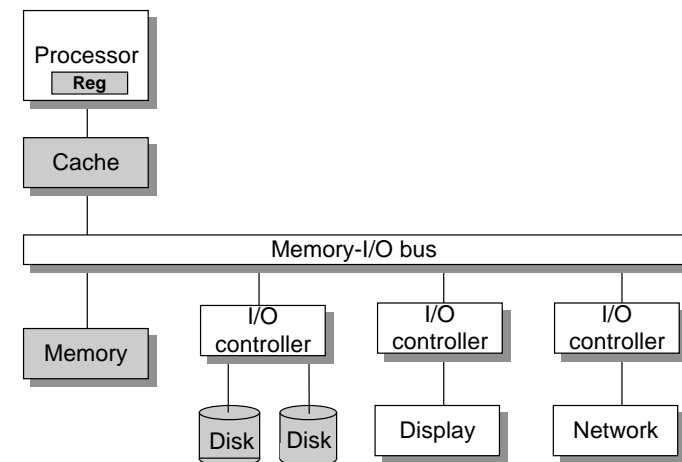
- **Speech recognition**
 - Will be routinely done with handheld devices
- **Breaking secret codes**
 - Need to use large enough keys
- **Digital Video**
 - Will stream just like today's MP3's

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Computer System

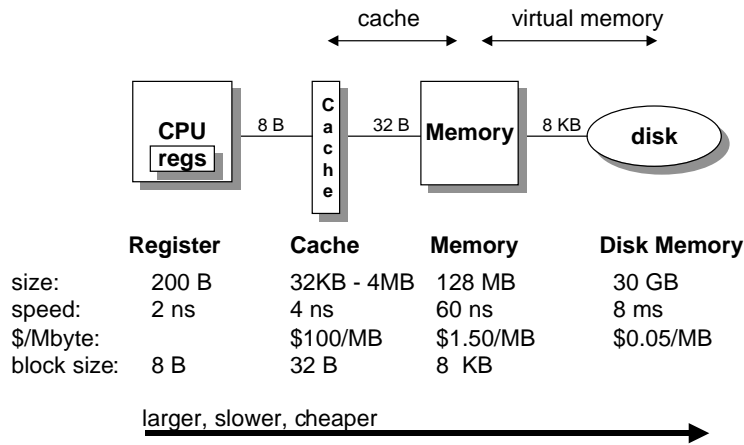


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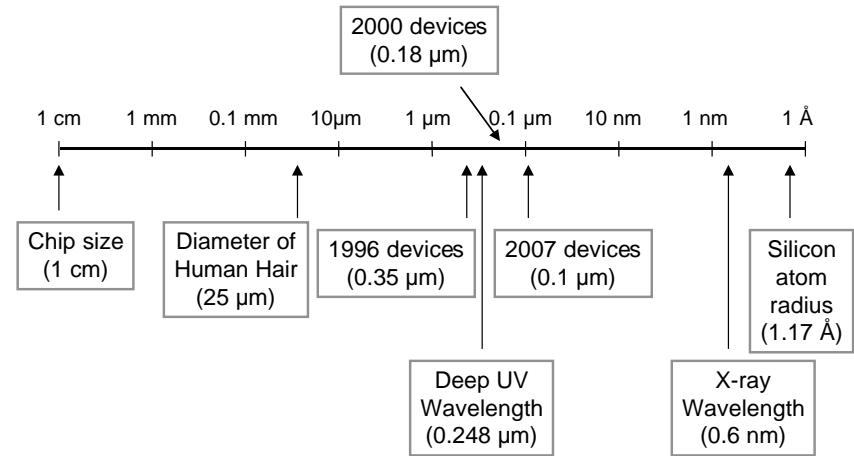
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Levels in Memory Hierarchy



Dimensions



Scaling to 0.1μm

- Semiconductor Industry Association, 1992 Technology Workshop
 - Projected future technology based on past trends

	1992	1995	1998	2001	2004	2007
Feature size (μm):	0.5	0.35	0.25	0.18	0.12	0.10
- Industry is slightly ahead of projection						
DRAM capacity:	16M	64M	256M	1G	4G	16G
- Doubles every 1.5 years						
- Prediction on track						
Chip area (cm²):	2.5	4.0	6.0	8.0	10.0	12.5
- Way off! Chips staying small						

Static RAM (SRAM)

Fast

- ~4 nsec access time

Persistent

- as long as power is supplied
- no refresh required

Expensive

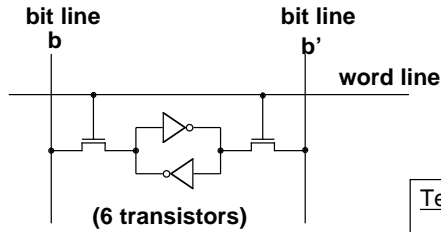
- ~\$100/MByte
- 6 transistors/bit

Stable

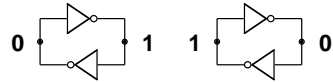
- High immunity to noise and environmental disturbances

Technology for caches

Anatomy of an SRAM Cell



Stable Configurations



Terminology:

bit line: carries data
word line: used for addressing

Write:

1. set bit lines to new data value
 - **b'** is set to the opposite of **b**
 2. raise word line to "high"
- ⇒ sets cell to new state (may involve flipping relative to old state)

Read:

1. set bit lines high
2. set word line high
3. see which bit line goes low

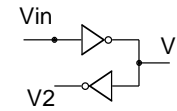
SRAM Cell Principle

Inverter Amplifies

- Negative gain
- Slope < -1 in middle
- Saturates at ends

Inverter Pair Amplifies

- Positive gain
- Slope > 1 in middle
- Saturates at ends



Dynamic RAM (DRAM)

Slower than SRAM

- access time ~60 nsec

Not persistent

- every row must be accessed every ~1 ms (refreshed)

Cheaper than SRAM

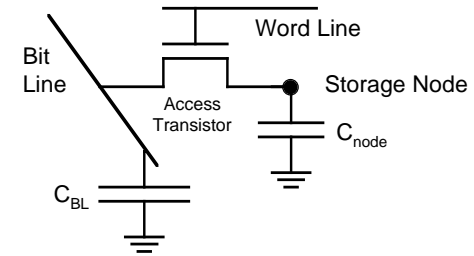
- ~\$1.50 / MByte
- 1 transistor/bit

Fragile

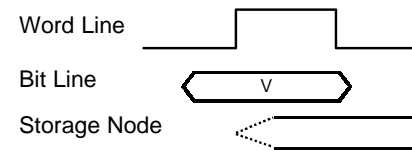
- electrical noise, light, radiation

Workhorse memory technology

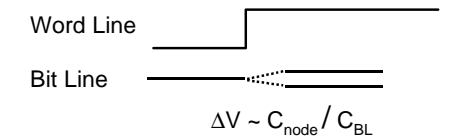
Anatomy of a DRAM Cell



Writing



Reading



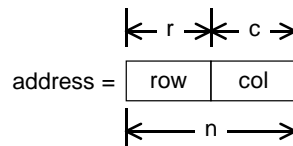
Addressing Arrays with Bits

Array Size

- R rows, $R = 2^r$
- C columns, $C = 2^c$
- $N = R * C$ bits of memory

Addressing

- Addresses are n bits, where $N = 2^n$
- $row(address) = address / C$
– leftmost r bits of address
- $col(address) = address \% C$
– rightmost bits of address



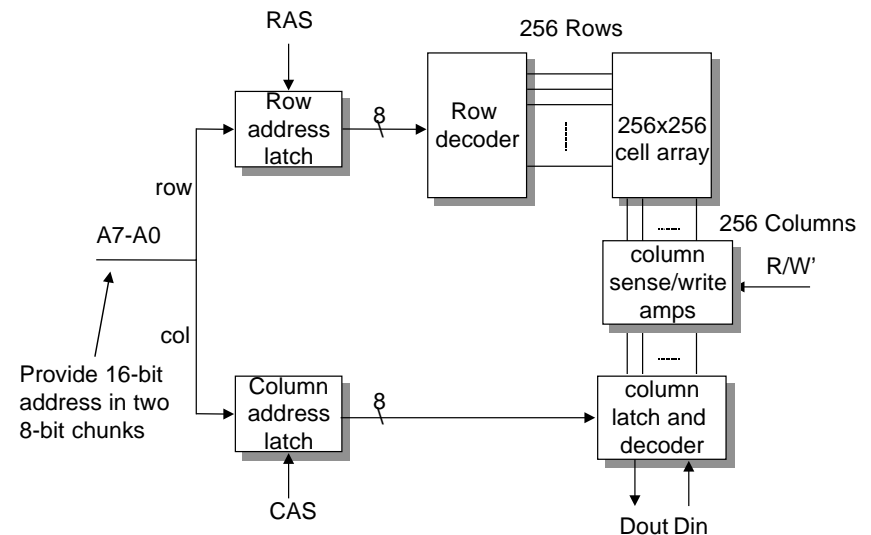
Example

- R = 2
- C = 4
- address = 6

	0	1	2	3
0	000	001	010	011
1	100	101	110	111

row 1 points to the second row (index 1). col 2 points to the third column (index 2). The cell at row 1, col 2 contains the value 110.

Example 2-Level Decode DRAM (64Kx1)



DRAM Operation

Row Address (~50ns)

- Set Row address on address lines & strobe RAS
- Entire row read & stored in column latches
- Contents of row of memory cells destroyed

Column Address (~10ns)

- Set Column address on address lines & strobe CAS
- Access selected bit
 - READ: transfer from selected column latch to Dout
 - WRITE: Set selected column latch to Din

Rewrite (~30ns)

- Write back entire row

Observations About DRAMs

Timing

- Access time (= 60ns) < cycle time (= 90ns)
- Need to rewrite row

Must Refresh Periodically

- Perform complete memory cycle for each row
- Approximately once every 1ms
- Sqrt(n) cycles
- Handled in background by memory controller

Inefficient Way to Get a Single Bit

- Effectively read entire row of Sqrt(n) bits

Enhanced Performance DRAMs

Conventional Access

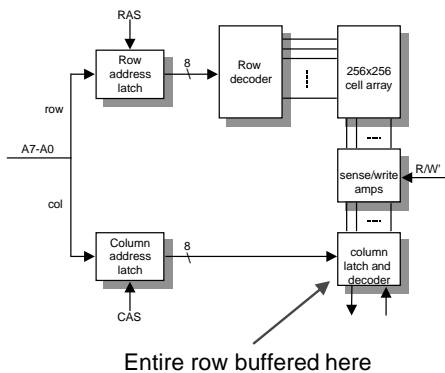
- Row + Col
- RAS CAS RAS CAS ...

Page Mode

- Row + Series of columns
- RAS CAS CAS CAS ...
- Gives successive bits

Other Acronyms

- EDORAM
 - “Extended data output”
- SDRAM
 - “Synchronous DRAM”



Typical Performance

row access time	col access time	cycle time	page mode cycle time
50ns	10ns	90ns	25ns

Video RAM

Performance Enhanced for Video / Graphics Operations

- Frame buffer to hold graphics image

Writing

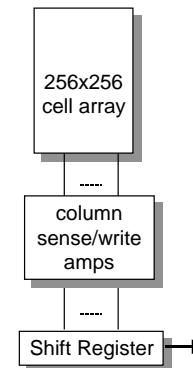
- Random access of bits
- Also supports rectangle fill operations
 - Set all bits in region to 0 or 1

Reading

- Load entire row into shift register
- Shift out at video rates

Performance Example

- 1200 X 1800 pixels / frame
- 24 bits / pixel
- 60 frames / second
- 2.8 GBits / second



Video Stream Output

DRAM Driving Forces

Capacity

- **4X per generation**
 - Square array of cells
- **Typical scaling**
 - Lithography dimensions 0.7X
 - » Areal density 2X
 - Cell function packing 1.5X
 - Chip area 1.33X
- **Scaling challenge**
 - Typically $C_{node} / C_{BL} = 0.1-0.2$
 - Must keep C_{node} high as shrink cell size

Retention Time

- Typically 16–256 ms
- Want higher for low-power applications

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DRAM Storage Capacitor

Planar Capacitor

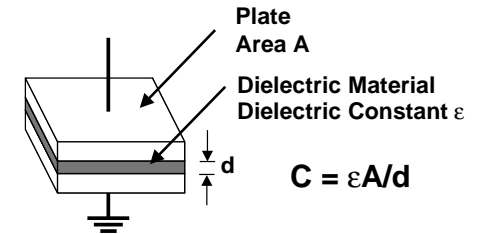
- Up to 1Mb
- C decreases linearly with feature size

Trench Capacitor

- 4 Mb –1 Gb
- Lining of hole in substrate

Stacked Cell

- $\geq 1\text{Gb}$
- On top of substrate
- Use high ϵ dielectric



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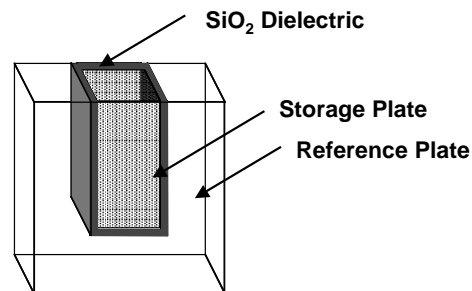
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Trench Capacitor

Process

- **Etch deep hole in substrate**
 - $\sim 5 \mu\text{m}$ deep
 - $\sim 0.5 \mu\text{m}$ diameter
 - Becomes reference plate
- **Grow oxide on walls**
 - Dielectric
- **Fill with polysilicon plug**
 - Tied to storage node



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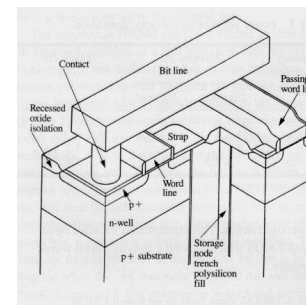
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IBM DRAM Cell

- IBM J. R&D, Jan/Mar '95
- Evolution from 4 – 256 Mb

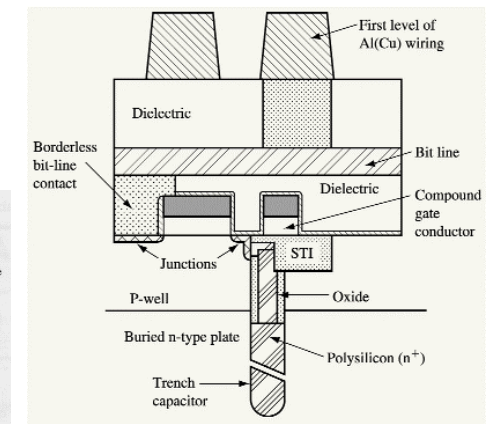
4 Mb Cell Structure



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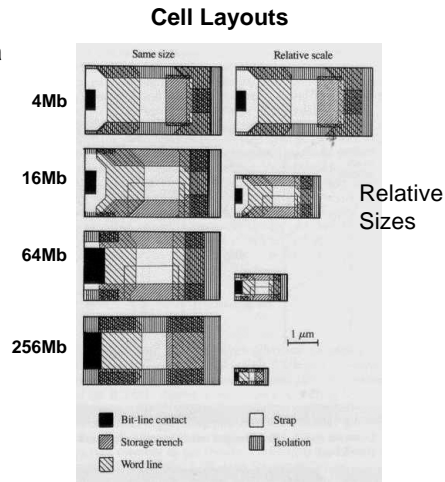
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IBM DRAM Evolution

- IBM J. R&D, Jan/Mar '95
- Evolution from 4 – 256 Mb
- 256 Mb uses cell with area 0.6 μm^2



Mitsubishi Stacked Cell DRAM

- IEDM '95
- Claim suitable for 1 – 4 Gb

Technology

- 0.14 μm process
- 8 nm gate oxide
- 0.29 μm^2 cell

Storage Capacitor

- Fabricated on top of everything else
- Rubidium electrodes
- High dielectric insulator
 - 50X higher than SiO_2
 - 25 nm thick
- Cell capacitance 25 femtofarads

Cross Section of 2 Cells

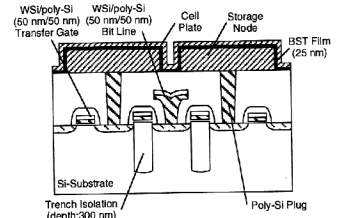


Fig. 2 Schematic cross-sectional view of DRAM memory cells with Ru/BST/Ru stacked capacitors.

Mitsubishi DRAM Pictures

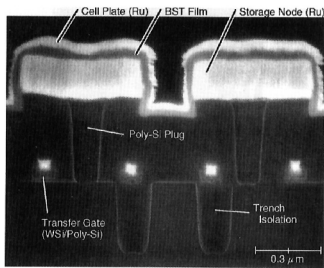


Fig. 3 SEM cross-sectional photograph of the fabricated 0.29- μm^2 memory cell with Ru/BST/Ru stacked capacitor. The facet was fabricated by focused ion beam etching.

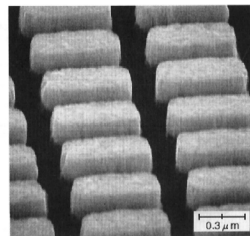


Fig. 8 SEM photograph of a Ru-metal storage node array with a projection a height of 0.2 μm .

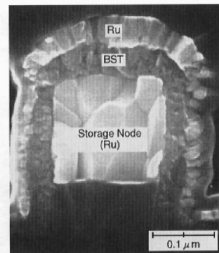
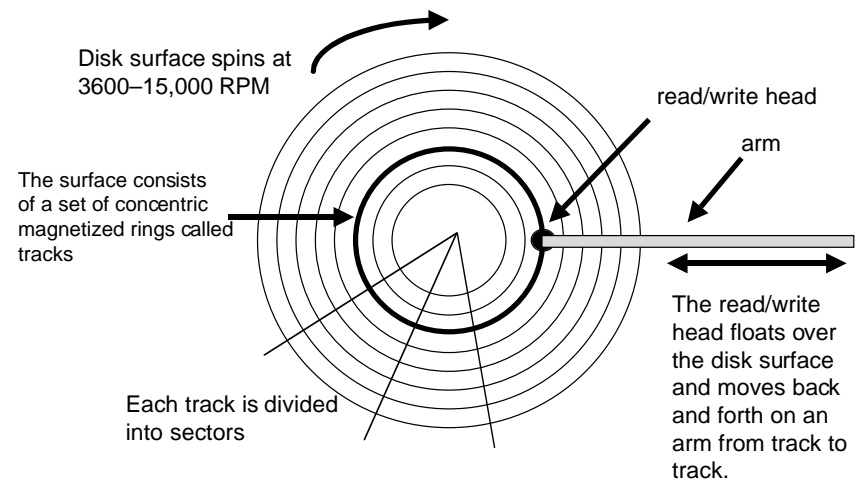


Fig. 10 SEM cross-sectional view of a Ru/BST/Ru capacitor cell. The facet shown is a cleaved facet.

Magnetic Disks



Disk Capacity

Parameter	18GB Example
• Number Platters	12
• Surfaces / Platter	2
• Number of tracks	6962
• Number sectors / track	213
• Bytes / sector	512
Total Bytes	18,221,948,928

Disk Operation

Operation

- Read or write complete sector

Seek

- Position head over proper track
- Typically 6-9ms

Rotational Latency

- Wait until desired sector passes under head
- Worst case: complete rotation
10,025 RPM \Rightarrow 6 ms

Read or Write Bits

- Transfer rate depends on # bits per track and rotational speed
- E.g., 213 * 512 bytes @10,025RPM = 18 MB/sec
- Modern disks have external transfer rates of up to 100 MB/sec

Disk Performance

Getting First Byte

- Seek + Rotational latency = 7,000 – 19,000 μ sec

Getting Successive Bytes

- ~ 0.06 μ sec each
– roughly 100,000 times faster than getting the first byte!

Optimizing Performance:

- Large block transfers are more efficient
- Try to do other things while waiting for first byte
 - switch context to other computing task
 - processor is interrupted when transfer completes

Disk / System Interface

1. Processor Signals Controller

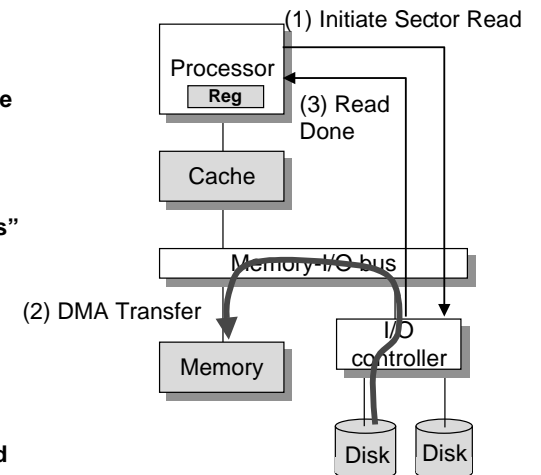
- Read sector X and store starting at memory address Y

2. Read Occurs

- “Direct Memory Access” (DMA) transfer
- Under control of I/O controller

3. I/O Controller Signals Completion

- Interrupts processor
- Can resume suspended process



Magnetic Disk Technology

Seagate ST-12550N Barracuda 2 Disk

- **Linear density** **52,187.** **bits per inch (BPI)**
 - Bit spacing 0.5 μm
 - Track density 3,047. tracks per inch (TPI)
 - Track spacing 8.3 μm
- **Total tracks** **2,707.** **tracks**
- **Rotational Speed** **7200.** **RPM**
- **Avg Linear Speed** **86.4** **kilometers / hour**
- **Head Floating Height** **0.13** **microns**

Analogy:

- put the Sears Tower on its side
- fly it around the world, **2.5cm** above the ground
- each complete orbit of the earth takes **8 seconds**

CD Read Only Memory (CDROM)

Basis

- **Optical recording technology developed for audio CDs**
 - 74 minutes playing time
 - 44,100 samples / second
 - 2 X 16-bits / sample (Stereo)
 - ⇒ Raw bit rate = 172 KB / second
- **Add extra 288 bytes of error correction for every 2048 bytes of data**
 - Cannot tolerate any errors in digital data, whereas OK for audio

Bit Rate

- **$172 * 2048 / (288 + 2048) = 150 \text{ KB / second}$**
 - For 1X CDROM
 - $N \times$ CDROM gives bit rate of $N * 150$
 - E.g., 12X CDROM gives 1.76 MB / second

Capacity

- **$74 \text{ Minutes} * 150 \text{ KB / second} * 60 \text{ seconds / minute} = 650 \text{ MB}$**

Storage Trends

SRAM

metric	1980	1985	1990	1995	2000	2000:1980
\$/MB	19,200	2,900	320	256	100	190
access (ns)	300	150	35	15	2	100

DRAM

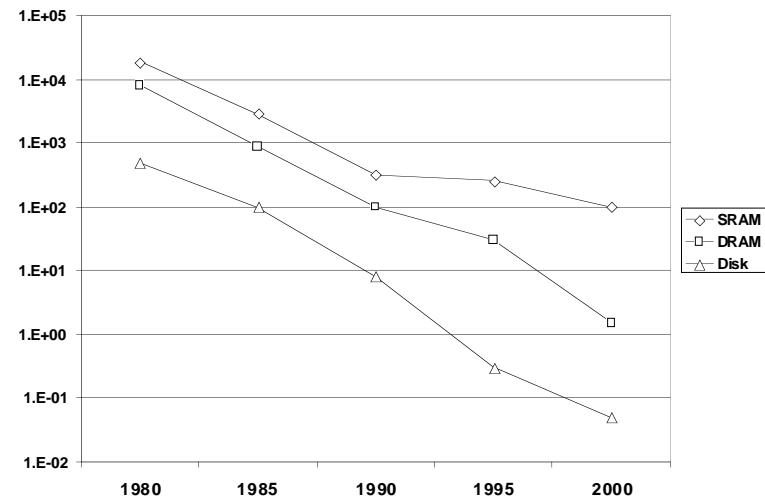
metric	1980	1985	1990	1995	2000	2000:1980
\$/MB	8,000	880	100	30	1.5	5,300
access (ns)	375	200	100	70	60	6
typical size(MB)	0.064	0.256	4	16	64	1,000

Disk

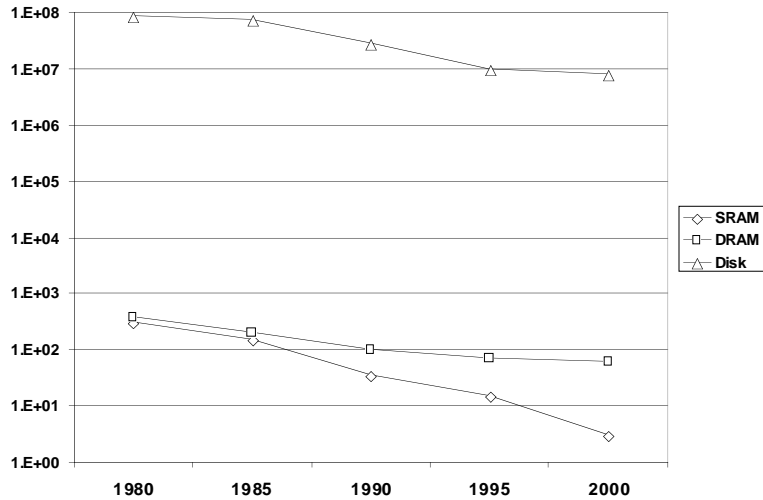
metric	1980	1985	1990	1995	2000	2000:1980
\$/MB	500	100	8	0.30	0.05	10,000
access (ms)	87	75	28	10	8	11
typical size(MB)	1	10	160	1,000	9,000	9,000

(Culled from back issues of Byte and PC Magazine)

Storage Price: \$/MByte



Storage Access Times (nsec)



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Processor clock rates

Processors

metric	1980	1985	1990	1995	2000	2000:1980
typical clock(MHz)	1	6	20	150	750	750
processor	8080	286	386	Pentium	P-III	

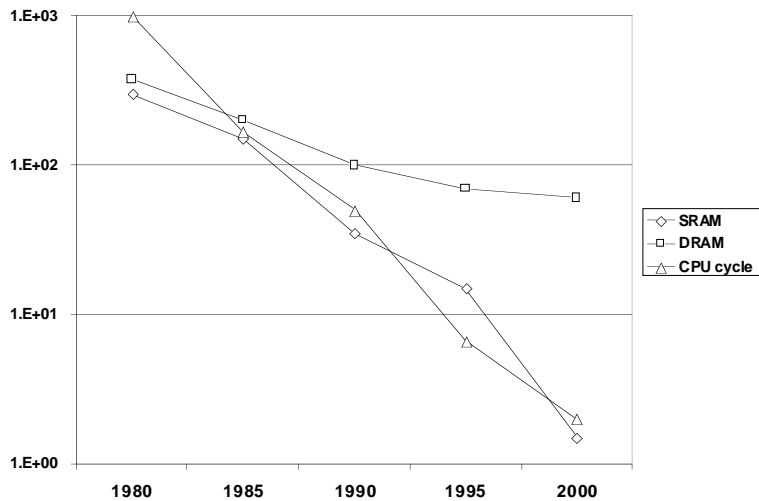
culled from back issues of Byte and PC Magazine

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The CPU vs. DRAM Latency Gap (ns)



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Memory Technology Summary

Cost and Density Improving at Enormous Rates

Speed Lagging Processor Performance

Memory Hierarchies Help Narrow the Gap:

- Small fast SRAMS (cache) at upper levels
- Large slow DRAMS (main memory) at lower levels
- Incredibly large & slow disks to back it all up

Locality of Reference Makes It All Work

- Keep most frequently accessed data in fastest memory

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